Application/Control No. Applicant(s)/Patent Under Reexamination 10/689,370 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Xiuqin Sun 2863 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,892,317	05-2005	Sampath et al.	714/4
*	В	US-6,225,999	05-2001	Jain et al.	715/734
	O	US-		·	
	D	US-			
	E	US-			
	F	US-			·
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.